# Supertex inc.



## P-Channel Enhancement Mode **Vertical DMOS FETs**

#### **Features**

- High input impedance and high gain
- Low power drive requirement
- Ease of paralleling ►
- Low C<sub>ISS</sub> and fast switching speeds
- Excellent thermal stability
- Integral source-drain diode
- Free from secondary breakdown

#### **Applications**

- Logic level interfaces ideal for TTL and CMOS
- Solid state relays
- Analog switches
- Power management
- **Telecom switches**

#### **General Description**

This low threshold enhancement-mode (normally-off) transistor utilizes a vertical DMOS structure and Supertex's well-proven silicon-gate manufacturing process. This combination produces a device with the power handling capabilities of bipolar transistors and with the high input impedance and positive temperature coefficient inherent in MOS devices. Characteristic of all MOS structures. this device is free from thermal runaway and thermallyinduced secondary breakdown.

Supertex's vertical DMOS FETs are ideally suited to a wide range of switching and amplifying applications where very low threshold voltage, high breakdown voltage, high input impedance, low input capacitance, and fast switching speeds are desired.

#### **Ordering Information**

Davis	Package O	ptions	BV <sub>DSS</sub> /BV <sub>DGS</sub>	R <sub>DS(ON)</sub>			
Device	TO-236AB (SOT-23)	TO-92	(V)	(max) (Ω)	(max) (V)		
TP2104	TP2104K1-G	TP2104N3-G	-40	6.0	-2.0		

Value

BV<sub>DSS</sub>

 $\mathsf{BV}_{\mathsf{DGS}}$ 

±20V

+300°C

-55°C to +150°C

compliant ('Green')

**Absolute Maximum Ratings** 



Drain-to-source voltage

Gate-to-source voltage

Soldering temperature\*

referenced to device ground.

Drain-to-gate voltage

Parameter

#### **Pin Configuration**



Distance of 1.6mm from case for 10 seconds.

Operating and storage temperature

Absolute Maximum Ratings are those values beyond which damage to the device may occur. Functional operation under these conditions is not implied. Continuous operation

of the device at the absolute rating level may affect device reliability. All voltages are

Package may or may not include the following marks: Si or TO-236AB (SOT-23) (K1)

#### **Thermal Characteristics**

Package	I <sub>D</sub> (continuous) <sup>†</sup> (mA)	I <sub>D</sub> (pulsed) (A)	Power Dissipation @ T <sub>A</sub> = 25°C (W)	<i>θ<sub>jc</sub></i> ∘C/W	θ <sub>ja</sub> °C/W	l <sub>DR</sub> † (mA)	l <sub>DRM</sub> (A)
TO-236AB (SOT-23)	-160	-0.8	0.36	200	350	-160	-0.8
TO-92	-250	-1.0	0.74	125	170	-250	-1.0

*†*  $I_{D}$  (continuous) is limited by max rated  $T_{i}$ .

#### **Electrical Characteristics** (*T<sub>A</sub>* = 25°C unless otherwise specified)

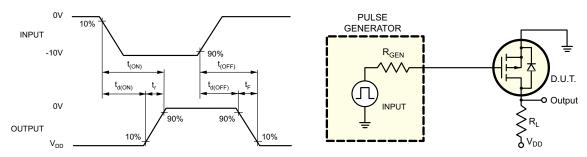
Sym	Parameter	Min	Тур	Мах	Units	Conditions		
BV <sub>DSS</sub>	Drain-to-source breakdown voltage	-40	-	-	V	V <sub>GS</sub> = 0V, I <sub>D</sub> = -1.0mA		
$V_{GS(th)}$	Gate threshold voltage	-1.0	-	-2.0	V	$V_{gs} = V_{Ds}, I_{D} = -1.0 \text{mA}$		
$\Delta V_{GS(th)}$	Change in $V_{_{GS(th)}}$ with temperature	-	5.8	6.5	mV/ºC	$V_{GS} = V_{DS}, I_{D} = -1.0 \text{mA}$		
I <sub>GSS</sub>	Gate body leakage	-	-1.0	-100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
			-	-10	μA	$V_{GS}$ = 0V, $V_{DS}$ = Max Rating		
I <sub>DSS</sub>	Zero gate voltage drain current	-	-	-1.0	mA	$V_{DS}$ = 0.8 Max Rating, $V_{GS}$ = 0V, $T_{A}$ = 125°C		
I <sub>D(ON)</sub>	On-state drain current	-0.6	-	-	А	V <sub>GS</sub> = -10V, V <sub>DS</sub> = -25V		
	Static drain-to-source on-state	-	-	10	Ω	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -50mA		
R <sub>DS(ON)</sub>	resistance		-	6.0		V <sub>GS</sub> = -10V, I <sub>D</sub> = -500mA		
$\Delta R_{DS(ON)}$	Change in $R_{DS(ON)}$ with temperature	-	0.55	1.0	%/°C	V <sub>GS</sub> = -10V, I <sub>D</sub> = -500mA		
G <sub>FS</sub>	Forward transconductance	150	200	-	mmho	V <sub>DS</sub> = -25V, I <sub>D</sub> = -500mA		
C <sub>ISS</sub>	Input capacitance	-	35	60		V <sub>GS</sub> = 0V,		
C <sub>oss</sub>	Common source output capacitance	-	22	30	pF	$V_{\rm DS} = -25V,$		
C <sub>RSS</sub>	Reverse transfer capacitance	-	8.0	10		f = 1.0 MHz		
t <sub>d(ON)</sub>	Turn-on delay time	-	4.0	6.0				
t,	Rise time	-	4.0	8.0	20	$V_{DD} = -25V,$		
t <sub>d(OFF)</sub>	Turn-off delay time		5.0	9.0	ns	$I_{D} = -500 \text{mA},$ $R_{GEN} = 25\Omega$		
t <sub>r</sub>	Fall time	-	5.0	8.0		GEN		
V <sub>SD</sub>	Diode forward voltage drop	-	-1.2	-2.0	V	V <sub>GS</sub> = 0V, I <sub>SD</sub> = -500mA		
t	Reverse recovery time	_	400	-	ns	$V_{gs} = 0V, I_{sp} = -500mA$		

Notes:

1. All D.C. parameters 100% tested at 25°C unless otherwise stated. (Pulse test: 300µs pulse, 2% duty cycle.)

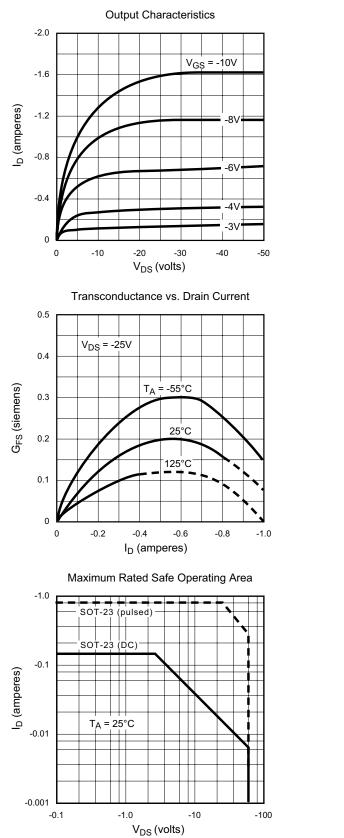
2. All A.C. parameters sample tested.

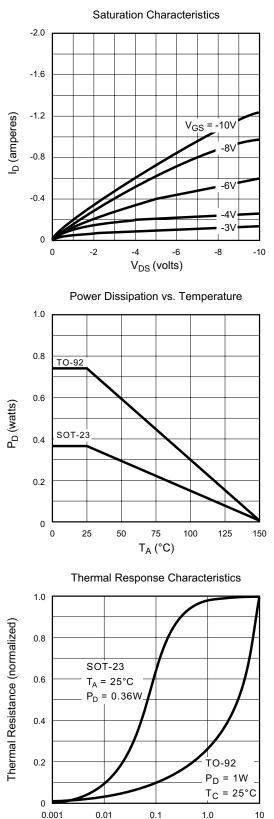
#### **Switching Waveforms and Test Circuit**



### TP2104

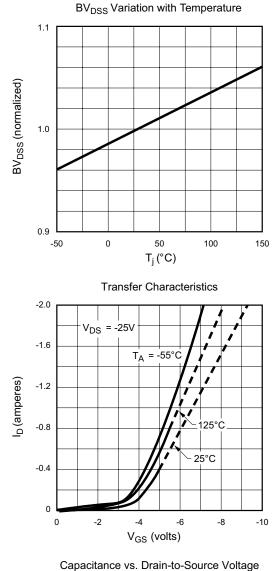
#### **Typical Performance Curves**



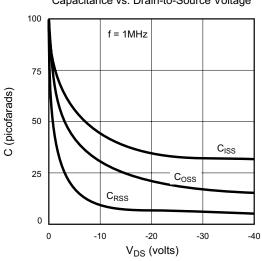


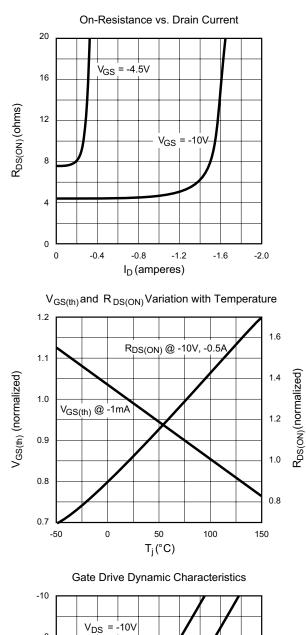
t<sub>p</sub> (seconds)

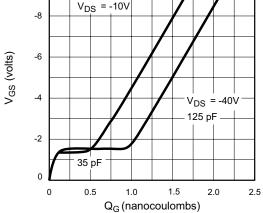
### TP2104



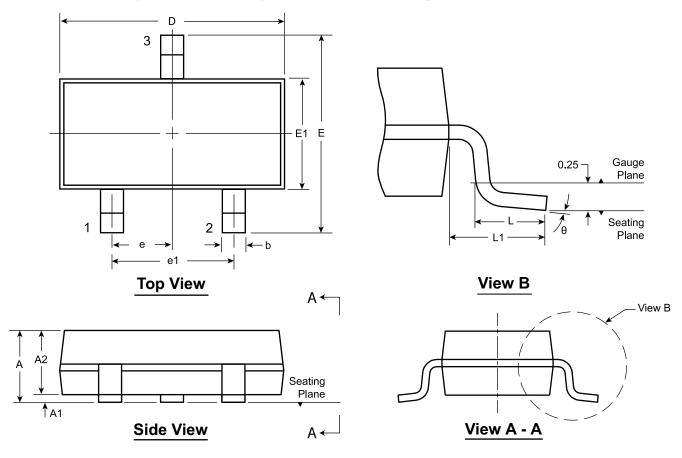
#### Typical Performance Curves (cont.)







### 3-Lead TO-236AB (SOT-23) Package Outline (K1) 2.90x1.30mm body, 1.12mm height (max), 1.90mm pitch



Symb	ol	Α	A1	A2	b	D	E	E1	е	e1	L	L1	θ		
Dimension (mm)	MIN	0.89	0.01	0.88	0.30	2.80	2.10	1.20	0.05	0.95 1.90 BSC BSC	0 50				<b>0</b> 0
	NOM	-	-	0.95	-	2.90	-	1.30				0.54 REF	-		
	MAX	1.12	0.10	1.02	0.50	3.04	2.64	1.40				0.60		<b>8</b> 0	

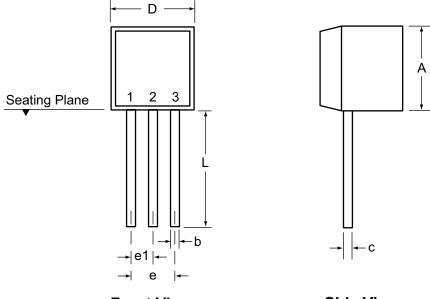
JEDEC Registration TO-236, Variation AB, Issue H, Jan. 1999.

† This dimension is a non-JEDEC dimension.

Drawings not to scale.

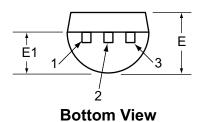
Supertex Doc.#: DSPD-3TO236ABK1, Version B072208.

## 3-Lead TO-92 Package Outline (N3)



Front View

**Side View** 



Symbol		Α	b	С	D	E	E1	е	e1	L
Dimensions (inches)	MIN	.170	.014†	.014†	.175	.125	.080	.095	.045	.500
	NOM	-	-	-	-	-	-	-	-	-
	MAX	.210	.022†	.022†	.205	.165	.105	.105	.055	.610*

JEDEC Registration TO-92.

\* This dimension is not specified in the original JEDEC drawing. The value listed is for reference only.

*†* This dimension is a non-JEDEC dimension.

Drawings not to scale.

Supertex Doc.#: DSPD-3TO92N3, Version D080408.

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